


<b>Search Notes</b> 	<b>Application/Control No.</b> 10594417	<b>Applicant(s)/Patent Under Reexamination</b> YASUDA ET AL.
	<b>Examiner</b> Scott D Long	<b>Art Unit</b> 1633

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
STN search - see attached sheet(s)	10/14/2008	SDL
EAST search - see attached sheet(s)	10/14/2008	SDL
PALM inventor search	10/14/2008	SDL

INTERFERENCE SEARCH			
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